

TEST REPORT

Test Report No. :	HK2506263445-6E	Aug. 26, 2025
Date of issue		

Equipment under Test	:	Smart Pet Collar
Model /Type	:	C10
Series Models	:	N/A
Applicant	:	Shenzhen Shire Star Electronic Technology Co., Ltd.
Address	:	2nd Floor, Building F, Guanghao Industrial Park, Yunfeng Road, Longhua District, Shenzhen, China
Manufacturer	:	Shenzhen Shire Star Electronic Technology Co., Ltd.
Address	:	2nd Floor, Building F, Guanghao Industrial Park, Yunfeng Road, Longhua District, Shenzhen, China

Test result	Pass
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The test report merely corresponds to the test sample.
It is not permitted to copy extracts of these test result without the written permission of the test laboratory.



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** Modified History **

Revision	Description	Issued Data	Remark
Revision 1.0	Initial Test Report Release	Aug. 26, 2025	Jason Zhou
		HUAN TESTING	



1 Summary

1.1 Test Standards

The tests were performed according to following standards:

[FCC Part 27: MISCELLANEOUS WIRELESS COMMUNICATIONS SERVICES](#)

47 CFR FCC Part 15 Subpart B: - Unintentional Radiators.

[FCC Part 2: FREQUENCY ALLOCATIONS AND RADIO TREATY MATTERS; GENERAL RULES AND REGULATIONS.](#)

[KDB971168 D01:v03r01: Measurement Guidance For Certification Of Licensed Digital Transmitters.](#)

1.2 Test Description

Test Item	Section in CFR 47	Result
RF Output Power	Part 2.1046 27.50 (b)(10)	Pass
Peak-to-Average Ratio	27.50 (d)(5)	Pass
99% & -26 dB Occupied Bandwidth	Part 2.1049 Part 27.53(h)	Pass
Spurious Emissions at Antenna Terminal	Part 2.1051 Part 27.53(h)	Pass
Field Strength of Spurious Radiation	Clause 7 of KDB971168 D01 v02r02	Pass
Out of band emission, Band Edge	2.1051 27.53 (c)(2) and (5), (h)(1) and (3)(i)	Pass
Frequency stability	2.1055 27.54	Pass



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1.3 Information of The Test Laboratory

Shenzhen HUAK Testing Technology Co., Ltd.

Add.: 1-2/F., Building B2, Junfeng Zhongcheng Zhizao Innovation Park, Heping, Fuhai Street, Bao'an District, Shenzhen, Guangdong, China

Testing Laboratory Authorization:

A2LA Accreditation Code is 4781.01.

FCC Designation Number is CN1229.

Canada IC CAB identifier is CN0045.

CNAS Registration Number is L9589.

1.4 Statement of The Measurement Uncertainty

The data and results referenced in this document are true and accurate. The reader is cautioned that there may be errors within the calibration limits of the equipment and facilities. The measurement uncertainty was calculated for all measurements listed in this test report acc. to CISPR 16 - 4 „Specification for radio disturbance and immunity measuring apparatus and methods – Part 4: Uncertainty in EMC Measurements“ and is documented in the Shenzhen HUAK Testing Technology Co., Ltd. quality system acc. to DIN EN ISO/IEC 17025. Furthermore, component and process variability of devices similar to that tested may result in additional deviation. The manufacturer has the sole responsibility of continued compliance of the device.

Hereafter the best measurement capability for Shenzhen HUAK Testing Technology Co., Ltd. is reported:

Test	Range	Measurement Uncertainty	Notes
Radiated Emission	30~1000MHz	4.10dB	(1)
Radiated Emission	Above 1GHz	4.32dB	(1)
Conducted Disturbance	0.15~30MHz	3.20dB	(1)

(1) This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.



2 General Information

2.1 General Remarks

Date of receipt of test sample	:	Jun. 26, 2025
Testing commenced on	:	Jun. 26, 2025
Testing concluded on	:	Aug. 26, 2025

2.2 Product Description

Name of EUT	Smart Pet Collar
Model/Type reference:	C10
Series Models:	N/A
Power supply:	DC5V From Adapter with AC100-240V, 50/60Hz, 0.5A Max or DC3.7V From Battery
Adapter Information	N/A
Modulation Type	QPSK, 16QAM
Antenna Type	FPC Antenna
Operation Frequency Band	LTE Band 13
Operation frequency	LTE Band 13: 777~787 MHz
LTE Release	R8
Extreme temp. Tolerance	-30°C to +50°C
Extreme vol. Limits	4.25VDC to 5.75VDC (nominal: 5.0VDC)

2.3 Equipment Under Test

Power supply system utilised

Power supply voltage	:	<input type="radio"/>	120V/ 60 Hz	<input type="radio"/>	115V/60Hz
		<input type="radio"/>	12 V DC	<input type="radio"/>	24 V DC
		<input checked="" type="radio"/>	Other (specified in blank below)		

DC5V From Adapter with AC100-240V, 50/60Hz, 0.5A Max or DC3.7V From Battery

Environmental Conditions

During the measurement the environmental conditions were within the listed ranges:

Normal Temperature:	25°C
Relative Humidity:	55 %
Air Pressure:	101 kPa

2.4 Description of Test Modes

The EUT has been tested under typical operating condition. The CMW500 used to control the EUT staying in continuous transmitting and receiving mode for testing. Regards to the frequency band operation: the lowest, middle and highest frequency of channel were selected to perform the test, then shown on this report.

Note:

1. For the ERP/EIRP and radiated emission test, every axis (X, Y, Z) was verified, and show the worst result on this report.
2. Test method and refer to 3GPP TS136521.



2.5 Equipments Used During The Test

Item	Test Equipment	Manufacturer	Model No.	Serial No.	Calibration Date	Calibration Due Date
1	L.I.S.N.	R&S	ENV216	HKE-002	2025/02/19	2026/02/18
2	L.I.S.N.	R&S	ENV216	HKE-059	2025/02/19	2026/02/18
3	EMI Test Receiver	R&S	ESR	HKE-005	2025/02/19	2026/02/18
4	Spectrum analyzer	Agilent	N9020A	HKE-117	2025/02/19	2026/02/18
5	Spectrum analyzer	R&S	FSV3044	HKE-126	2025/02/19	2026/02/18
6	Preamplifier	EMCI	EMC051845S	HKE-006	2025/02/19	2026/02/18
7	Preamplifier	Schwarzbeck	BBV 9743	HKE-016	2025/02/19	2026/02/18
8	Preamplifier	A.H. Systems	SAS-574	HKE-182	2025/02/19	2026/02/18
9	6dB Attenuator	Pasternack	6db	HKE-184	2025/02/19	2026/02/18
10	EMI Test Receiver	Rohde & Schwarz	ESR-7	HKE-010	2024/02/20	2025/02/19
11	Broadband Antenna	Schwarzbeck	VULB9168	HKE-167	2024/02/21	2026/02/20
12	Loop Antenna	COM-POWER	AL-130R	HKE-014	2024/02/21	2026/02/20
13	Horn Antenna	Schwarzbeck	9120D	HKE-013	2024/02/21	2026/02/20
14	EMI Test Software	Tonscend	JS32-CE 2.5.0.6	HKE-081	/	/
15	EMI Test Software	Tonscend	JS32-RE 5.0.0	HKE-082	/	/
16	RF Automatic control unit	Tonscend	JS0806-1	HKE-096	2025/02/19	2026/02/18
17	High pass filter unit	Tonscend	JS0806-F	HKE-055	2025/02/19	2026/02/18
18	Wireless Communication Test Set	R&S	CMU200	HKE-026	2025/02/19	2026/02/18
19	Wireless Communication Test Set	R&S	CMW500	HKE-027	2025/02/19	2026/02/18
20	High-low temperature chamber	Guangke	HT-80L	HKE-118	2025/06/09	2026/06/08
21	Temperature and humidity meter	Boyang	HTC-1	HKE-075	2025/06/09	2026/06/08
22	RF Test Software	Tonscend	JS1120 Version 3.5.39	HKE-183	/	/
23	RSE Test Software	Tonscend	JS36-RSE 5.0.0	HKE-184	/	/

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Band13	5MHz	16QAM	23230	12RB#0	23.20
Band13	5MHz	16QAM	23230	12RB#6	21.69
Band13	5MHz	16QAM	23230	12RB#13	22.61
Band13	5MHz	16QAM	23230	25RB#0	21.74
Band13	5MHz	QPSK	23255	1RB#0	23.75
Band13	5MHz	QPSK	23255	1RB#12	23.57
Band13	5MHz	QPSK	23255	1RB#24	23.69
Band13	5MHz	QPSK	23255	12RB#0	23.35
Band13	5MHz	QPSK	23255	12RB#6	23.45
Band13	5MHz	QPSK	23255	12RB#13	23.34
Band13	5MHz	QPSK	23255	25RB#0	23.41
Band13	5MHz	16QAM	23255	1RB#0	24.36
Band13	5MHz	16QAM	23255	1RB#12	22.71
Band13	5MHz	16QAM	23255	1RB#24	23.20
Band13	5MHz	16QAM	23255	12RB#0	21.56
Band13	5MHz	16QAM	23255	12RB#6	21.59
Band13	5MHz	16QAM	23255	12RB#13	21.51
Band13	5MHz	16QAM	23255	25RB#0	22.48
Band13	10MHz	QPSK	23230	1RB#0	23.57
Band13	10MHz	QPSK	23230	1RB#24	23.88
Band13	10MHz	QPSK	23230	1RB#49	23.90
Band13	10MHz	QPSK	23230	25RB#0	23.27
Band13	10MHz	QPSK	23230	25RB#12	22.80
Band13	10MHz	QPSK	23230	25RB#25	23.17
Band13	10MHz	QPSK	23230	50RB#0	23.29
Band13	10MHz	16QAM	23230	1RB#0	23.95
Band13	10MHz	16QAM	23230	1RB#24	23.46
Band13	10MHz	16QAM	23230	1RB#49	23.06
Band13	10MHz	16QAM	23230	25RB#0	23.30
Band13	10MHz	16QAM	23230	25RB#12	21.64
Band13	10MHz	16QAM	23230	25RB#25	22.52

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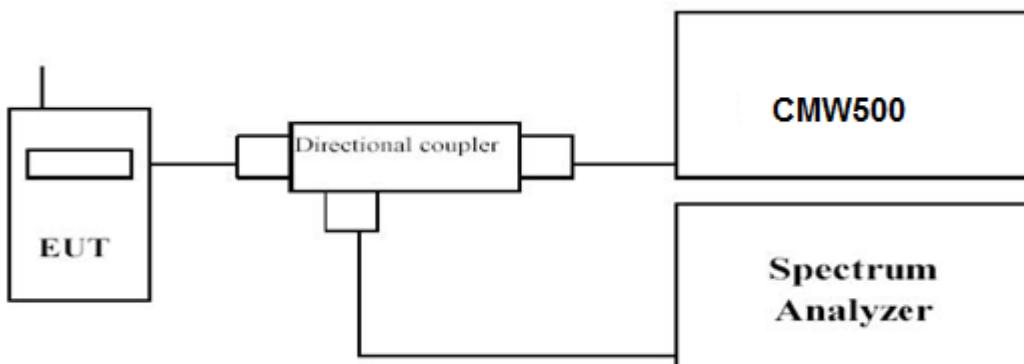
Add.: 1-2/F., Building B2, Junfeng Zhongcheng Zhizao Innovation Park, Heping, Fuhai Street, Bao'an District, Shenzhen, Guangdong, China

3.3 Peak-to-Average Ratio (PAR)

LIMIT

The Peak-to-Average Ratio (PAR) of the transmission may not exceed 13 dB.

TEST CONFIGURATION



TEST PROCEDURE

1. Refer to instrument's analyzer instruction manual for details on how to use the power statistics/CCDF function;
2. Set resolution/measurement bandwidth \geq signal's occupied bandwidth;
3. Set the number of counts to a value that stabilizes the measured CCDF curve;
4. Set the measurement interval as follows:
 - 1). for continuous transmissions, set to 1 ms;
 - 2). for burst transmissions, employ an external trigger that is synchronized with the EUT burst timing sequence, or use the internal burst trigger with a trigger level that allows the burst to stabilize and set the measurement interval to a time that is less than or equal to the burst duration.
5. Record the maximum PAPR level associated with a probability of 0.1%.

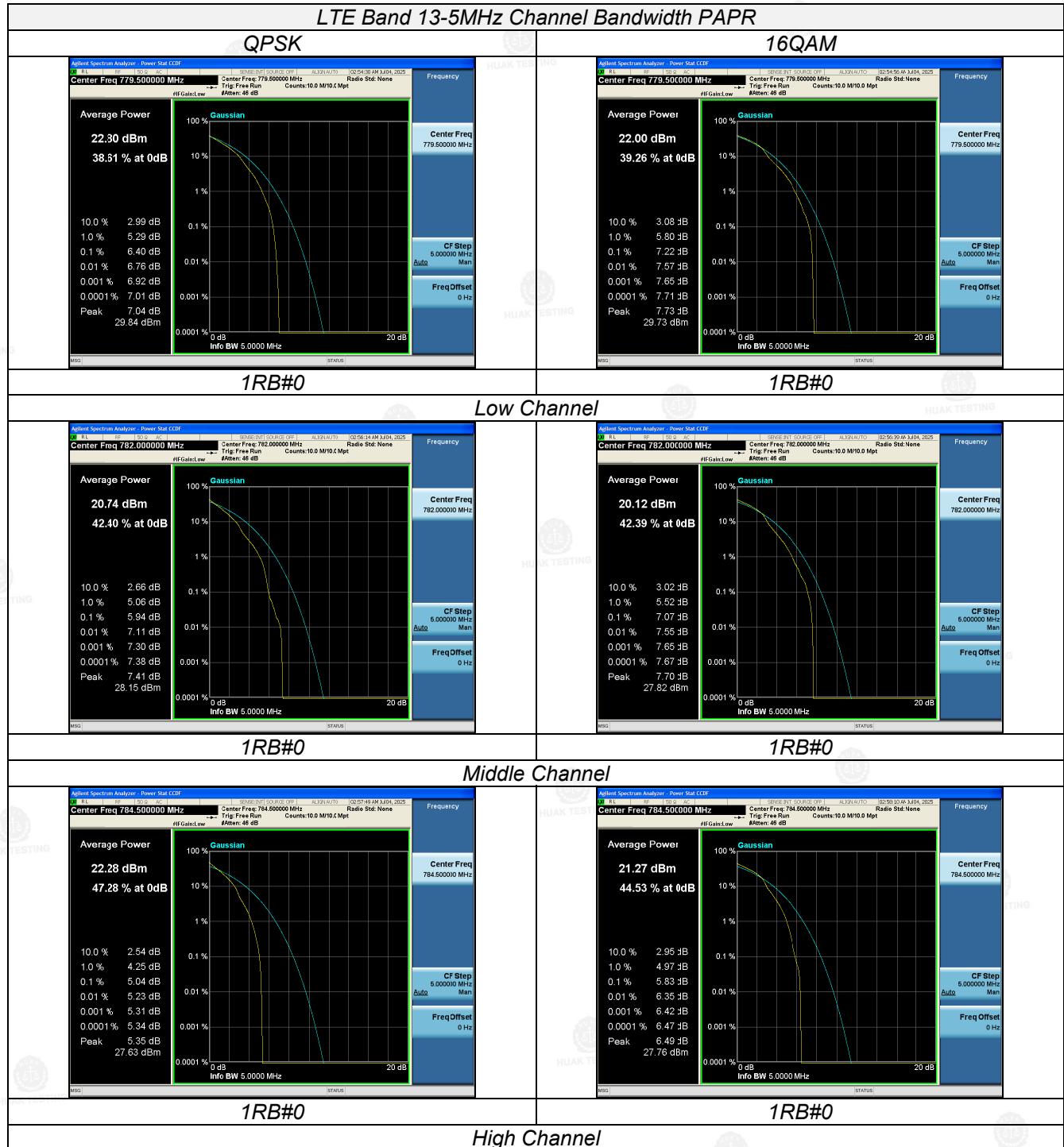
TEST RESULTS

Remark:

1. **We were tested all RB Configuration refer 3GPP TS136.521 for each Channel Bandwidth of LTE Band 13; recorded worst case for each Channel Bandwidth of LTE Band 13.**

LTE Band 13				
TX Channel Bandwidth	Frequency (MHz)	RB Size/Offset	PAPR (dB)	
			QPSK	16QAM
5 MHz	779.5	1RB#0	6.40	7.22
	782		5.94	7.07
	784.5		5.04	5.83
10 MHz	782	HUAK TESTING	1RB#0	6.94
				7.53

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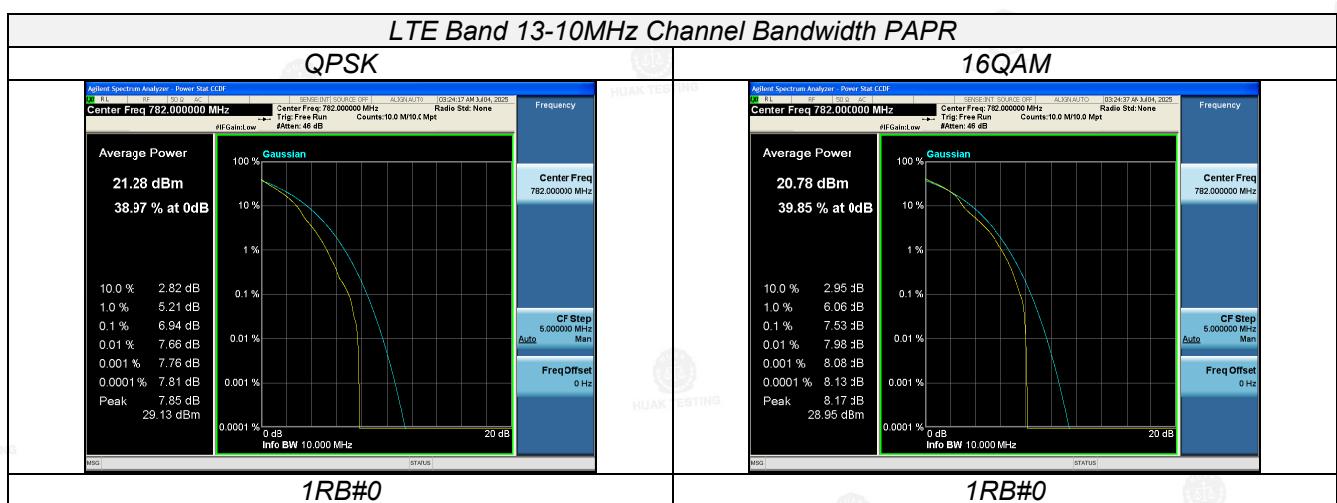


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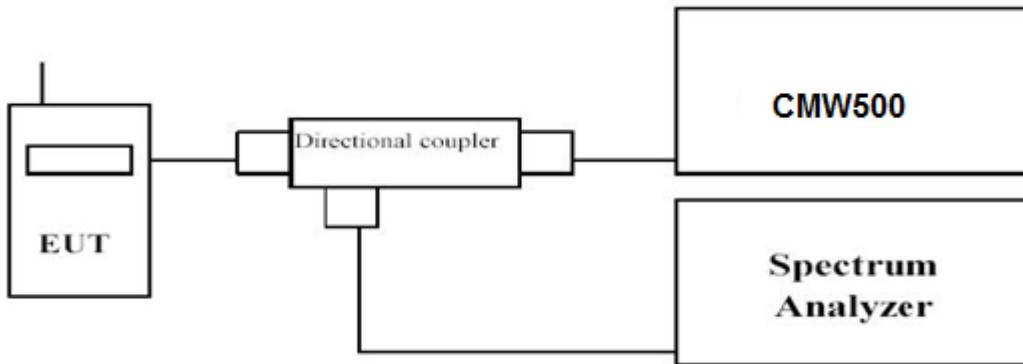


3.4 Occupied Bandwidth and Emission Bandwidth

LIMIT

NA

TEST CONFIGURATION



TEST PROCEDURE

The transmitter output was connected to a calibrated coaxial cable and coupler, the other end of which was connected to a spectrum analyzer. The occupied bandwidth was measured with the spectrum analyzer at low, middle and high channel in each band. The -26dBc Emission bandwidth was also measured and recorded. Set RBW was set to about 1% of emission BW. VRW>3 times RBW.

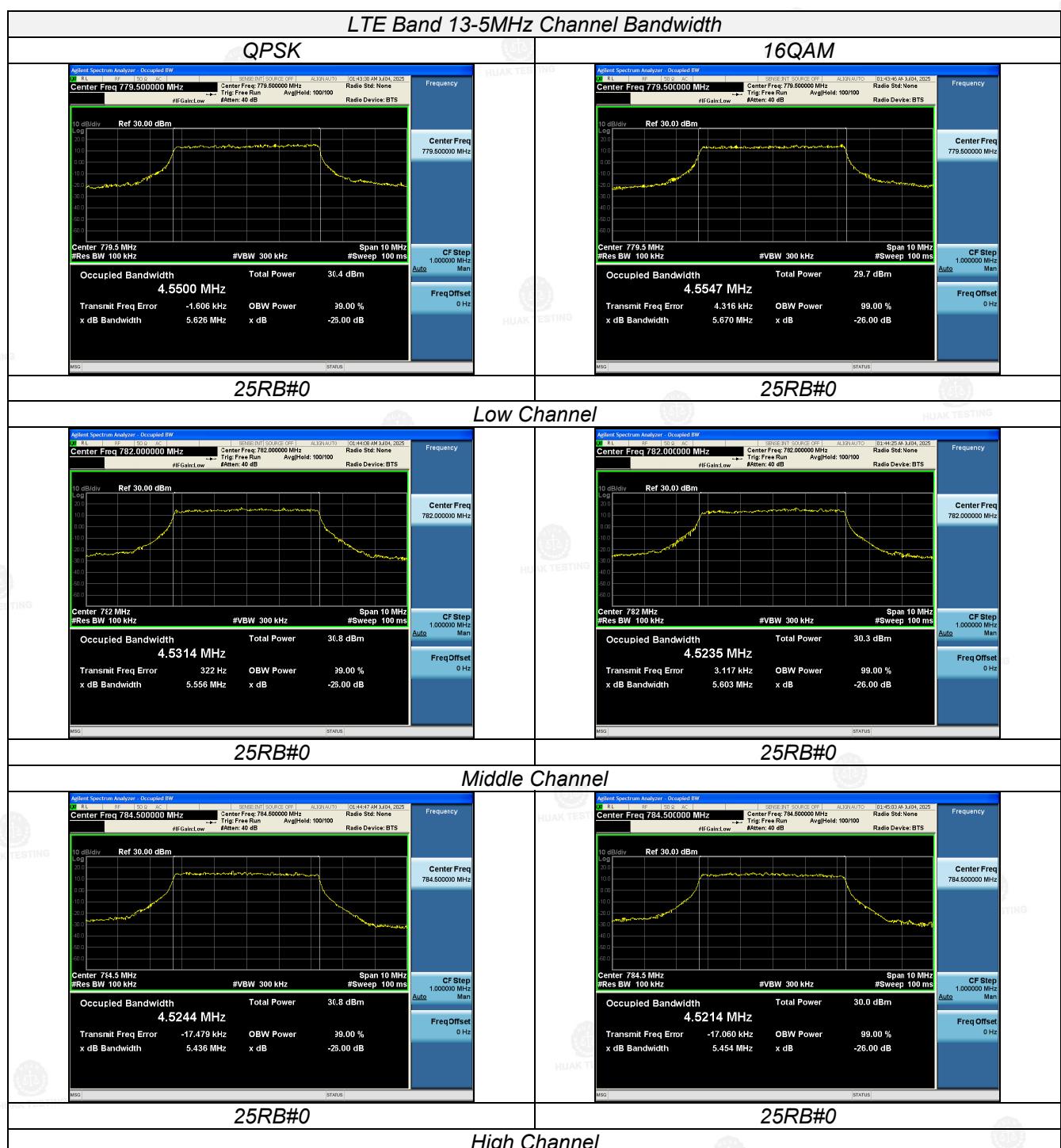
-26dBc display line was placed on the screen (or 99% bandwidth), the occupied bandwidth is the delta frequency between the two points where the display line intersects the signal trace.

TEST RESULTS

Remark:

1. We were tested all RB Configuration refer 3GPP TS136 521 for each Channel Bandwidth of LTE Band 13; recorded worst case for each Channel Bandwidth of LTE Band 13.

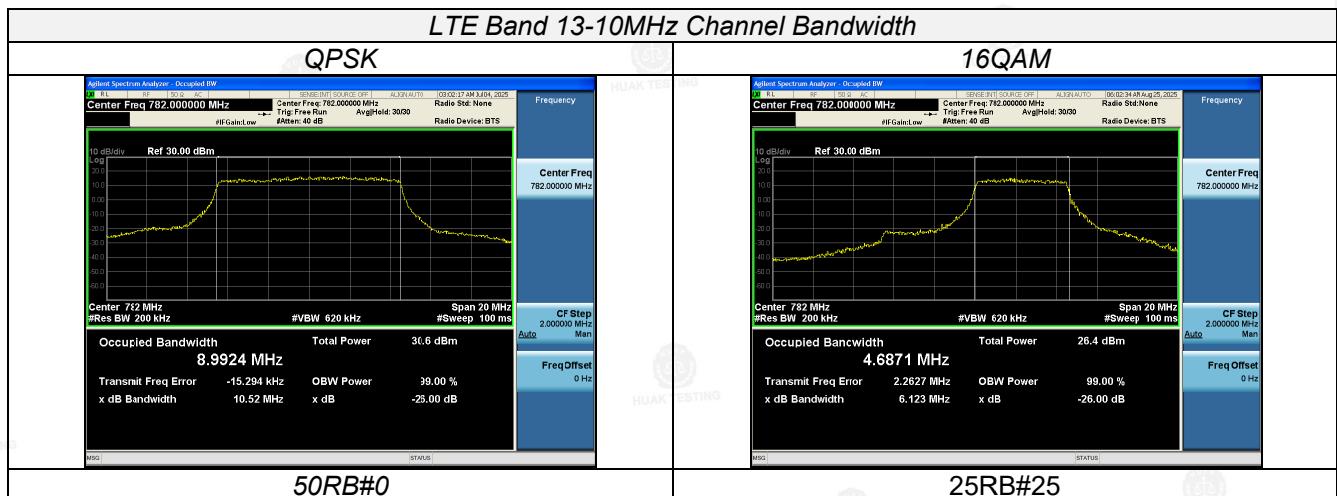
LTE Band 13						
TX Channel Bandwidth	RB Size/Offset	Frequency (MHz)	-26dBc Emission bandwidth (MHz)		99% Occupied bandwidth (MHz)	
			QPSK	16QAM	QPSK	16QAM
5 MHz	25RB#0	779.5	5.626	5.670	4.5500	4.5547
		782	5.556	5.603	4.5314	4.5235
		784.5	5.436	5.454	4.5244	4.5214
10 MHz	50RB#0	782	10.520	6.123	8.9924	4.6871



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3.5 Band Edge Compliance

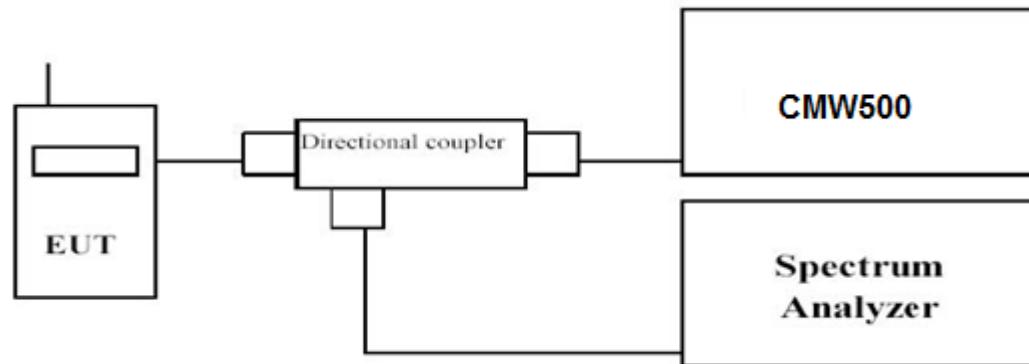
LIMIT

According to §27.53 (c): For operations in the 746-758 MHz band and the 776-788 MHz band, the power of any emission outside the licensee's frequency band(s) of operation shall be attenuated below the transmitter power (P) within the licensed band(s) of operation, measured in watts, in accordance with the following:

power (P) within the licensed band(s) of operation, measured in watts, in accordance with the following:

- (1) On any frequency outside the 746-758 MHz band, the power of any emission shall be attenuated outside the band below the transmitter power (P) by at least $43 + 10 \log (P)$ dB;
- (2) On any frequency outside the 776-788 MHz band, the power of any emission shall be attenuated outside the band below the transmitter power (P) by at least $43 + 10 \log (P)$ dB;
- (3) On all frequencies between 763-775 MHz and 793-805 MHz, by a factor not less than $76 + 10 \log (P)$ dB in a 6.25 kHz band segment, for base and fixed stations;
- (4) On all frequencies between 763-775 MHz and 793-805 MHz, by a factor not less than $65 + 10 \log (P)$ dB in a 6.25 kHz band segment, for mobile and portable stations;

TEST CONFIGURATION



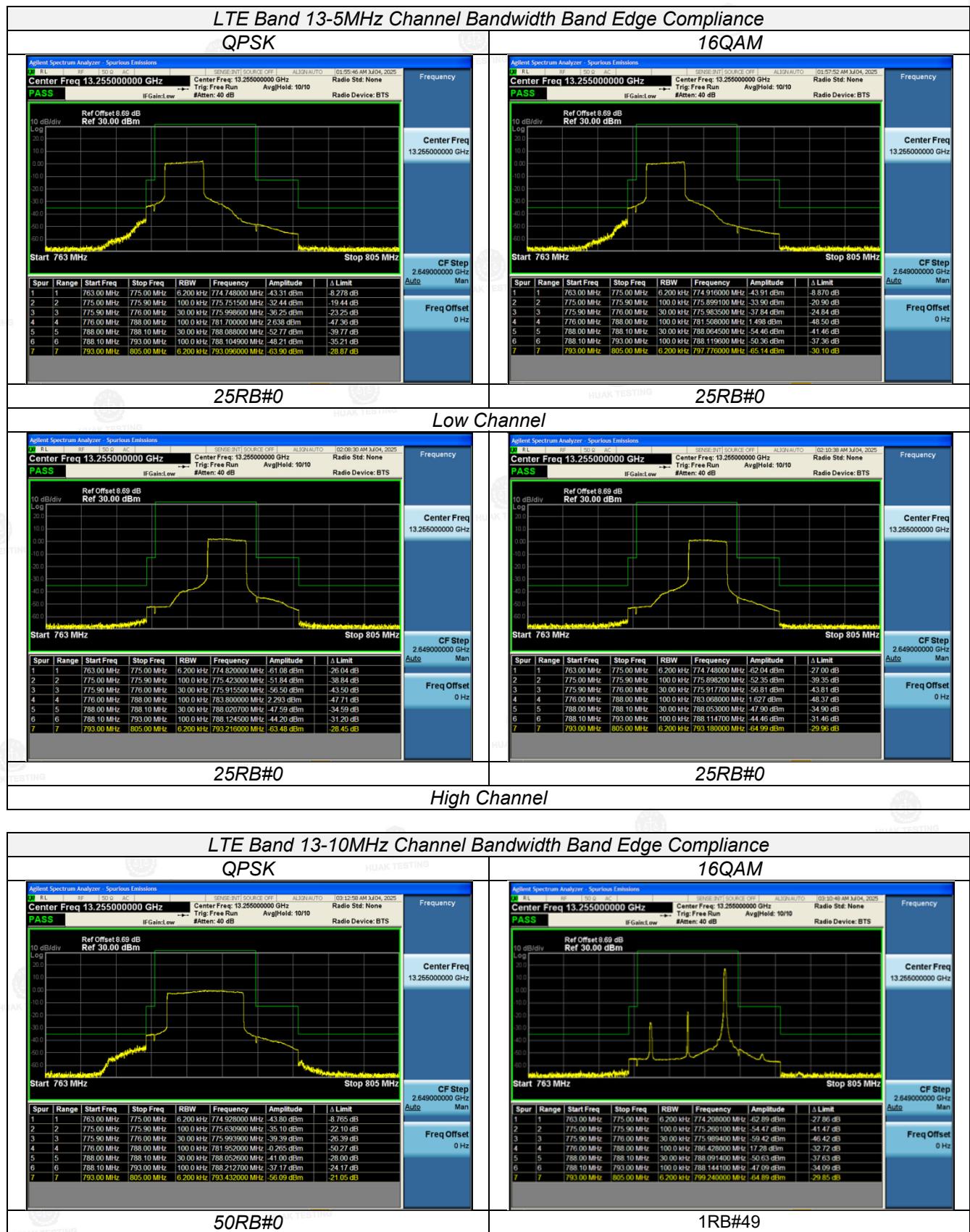
TEST PROCEDURE

1. The transmitter output port was connected to base station.
2. The RF output of EUT was connected to the power meter by RF cable and attenuator, the path loss was compensated to the results for each measurement.
3. Set EUT at maximum power through base station.
4. Select lowest and highest channels for each band and different modulation.
5. Measure Band edge using RMS (Average) detector by spectrum.

TEST RESULTS

Remark:

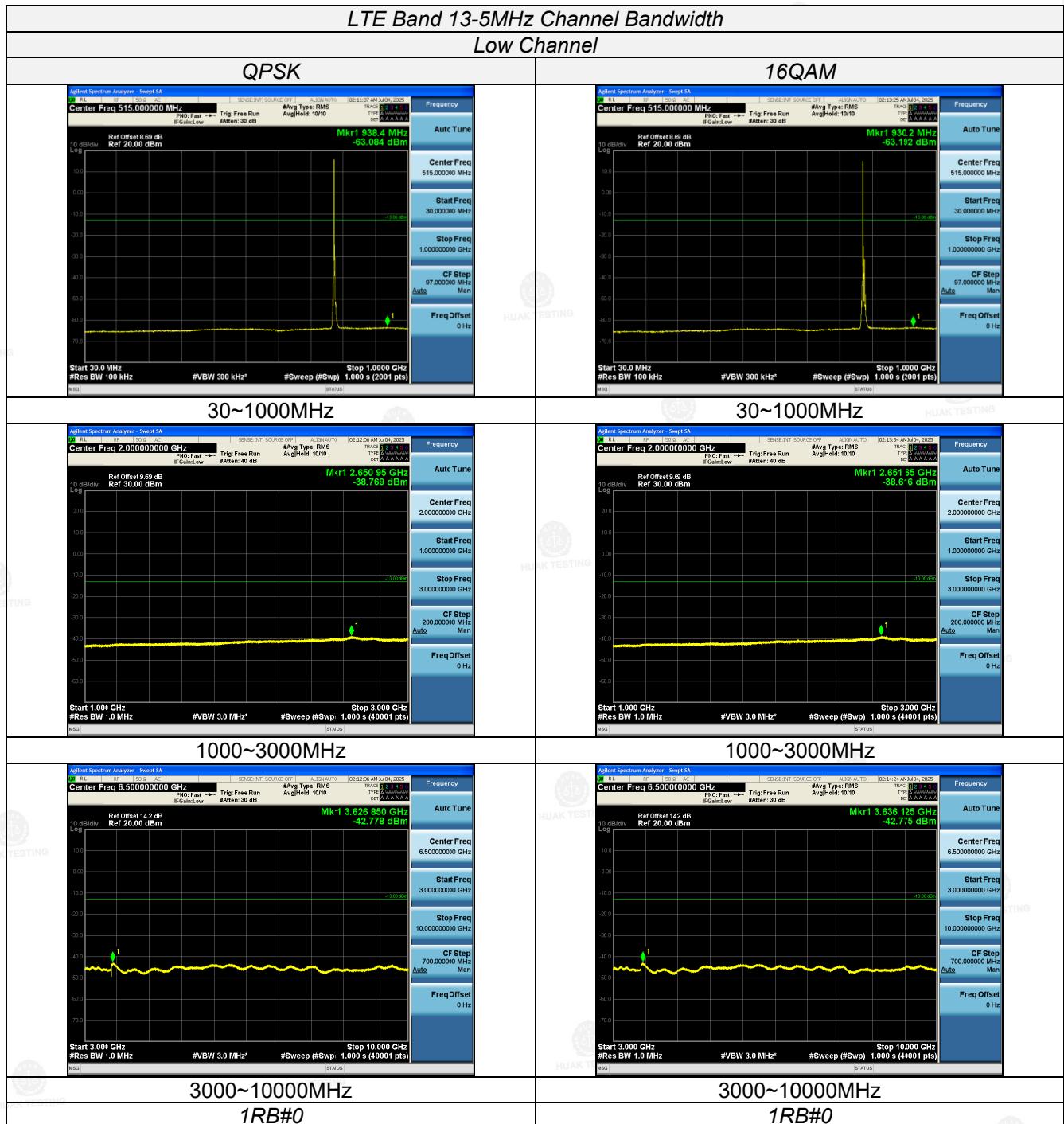
1. We were tested all RB Configuration refer 3GPP TS136 521 for each Channel Bandwidth of LTE Band 13; recorded worst case for each Channel Bandwidth of LTE Band 13.



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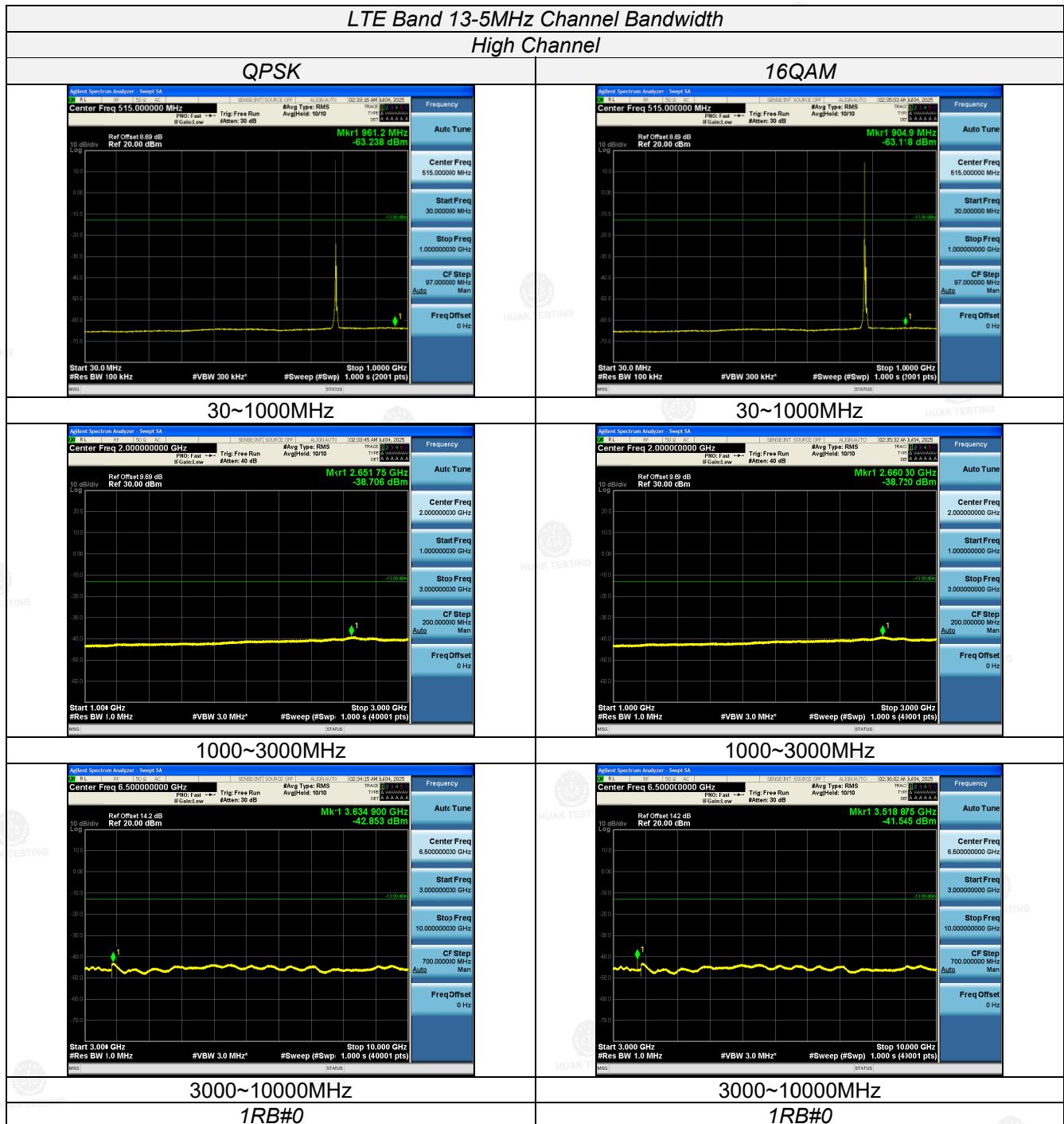


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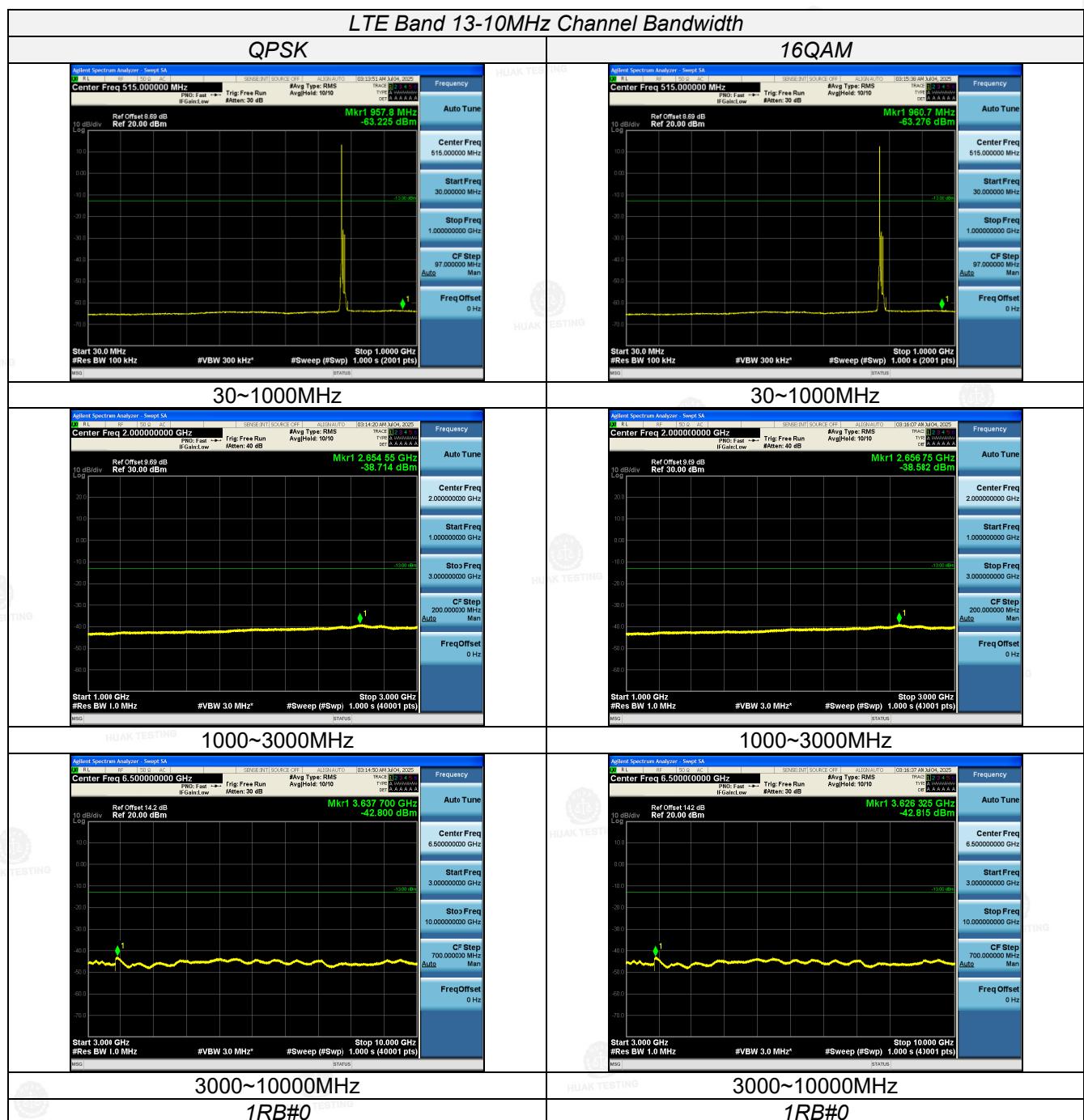
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Radiated Measurement:**Remark:**

1. We were tested all RB Configuration refer 3GPP TS136 521 for each Channel Bandwidth of LTE FDD Band 13; recorded worst case for each Channel Bandwidth of LTE FDD Band 13.
2. $EIRP = P_{Mea}(dBm) - P_{cl}(dB) + G_a(dBi)$
3. We were not recorded other points as values lower than limits.
4. Margin = Limit - EIRP

Radiated Measurement:**Remark:**

1. We were tested all RB Configuration refer 3GPP TS136 521 for each Channel Bandwidth of LTE FDD Band 13; recorded worst case for each Channel Bandwidth of LTE FDD Band 13.
2. $EIRP = P_{Mea}(dBm) - P_{cl}(dB) + G_a(dBi)$
3. We were not recorded other points as values lower than limits.
4. Margin = Limit - EIRP

LTE FDD Band 13_Channel Bandwidth 5MHz_QPSK_Low Channel

Frequency (MHz)	PMea (dBm)	Pcl (dB)	Diatance	Ga Antenna Gain(dB)	Peak EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
1559.0	-54.62	4.02	3.00	12.21	-46.43	-40.00	6.43	H
2338.5	-48.16	5.11	3.00	13.26	-40.01	-13.00	27.01	H
1559.0	-58.07	4.02	3.00	12.21	-49.88	-40.00	9.88	V
2338.5	-54.54	5.11	3.00	13.26	-46.39	-13.00	33.39	V

LTE FDD Band 13_Channel Bandwidth 5MHz_QPSK_Middle Channel

Frequency (MHz)	PMea (dBm)	Pcl (dB)	Diatance	Ga Antenna Gain(dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
1564.0	-53.12	4.02	3.00	12.21	-44.93	-40.00	4.93	H
2346.0	-46.99	5.11	3.00	13.26	-38.84	-13.00	25.84	H
1564.0	-58.44	4.02	3.00	12.21	-50.25	-40.00	10.25	V
2346.0	-54.10	5.11	3.00	13.26	-45.95	-13.00	32.95	V

LTE FDD Band 13_Channel Bandwidth 5MHz_QPSK_High Channel

Frequency (MHz)	PMea (dBm)	Pcl (dB)	Diatance	Ga Antenna Gain(dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
1569.0	-53.70	4.02	3.00	12.21	-45.51	-40.00	5.51	H
2353.5	-47.15	5.11	3.00	13.26	-39.00	-13.00	26.00	H
1569.0	-59.21	4.02	3.00	12.21	-51.02	-40.00	11.02	V
2353.5	-53.66	5.11	3.00	13.26	-45.51	-13.00	32.51	V

LTE FDD Band 13_Channel Bandwidth 10MHz_QPSK

Frequency (MHz)	PMea (dBm)	Pcl (dB)	Diatance	Ga Antenna Gain(dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
1564.0	-55.03	4.02	3.00	12.21	-46.84	-40.00	6.84	H
2346.0	-47.89	5.11	3.00	13.26	-39.74	-13.00	26.74	H
1564.0	-57.90	4.02	3.00	12.21	-49.71	-40.00	9.71	V
2346.0	-54.67	5.11	3.00	13.26	-46.52	-13.00	33.52	V

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LTE FDD Band 13_Channel Bandwidth 5MHz_16QAM_Low Channel

Frequency (MHz)	PMea (dBm)	Pcl (dB)	Diatance	Ga Antenna Gain(dB)	Peak EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
1559.0	-55.20	4.02	3.00	12.21	-47.01	-40.00	7.01	H
2338.5	-48.03	5.11	3.00	13.26	-39.88	-13.00	26.88	H
1559.0	-57.70	4.02	3.00	12.21	-49.51	-40.00	9.51	V
2338.5	-54.14	5.11	3.00	13.26	-45.99	-13.00	32.99	V

LTE FDD Band 13_Channel Bandwidth 5MHz_16QAM_Middle Channel

Frequency (MHz)	PMea (dBm)	Pcl (dB)	Diatance	Ga Antenna Gain(dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
1564.0	-53.44	4.02	3.00	12.21	-45.25	-40.00	5.25	H
2346.0	-46.42	5.11	3.00	13.26	-38.27	-13.00	25.27	H
1564.0	-58.28	4.02	3.00	12.21	-50.09	-40.00	10.09	V
2346.0	-54.55	5.11	3.00	13.26	-46.40	-13.00	33.40	V

LTE FDD Band 13_Channel Bandwidth 5MHz_16QAM_High Channel

Frequency (MHz)	PMea (dBm)	Pcl (dB)	Diatance	Ga Antenna Gain(dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
1569.0	-54.35	4.02	3.00	12.21	-46.16	-40.00	6.16	H
2353.5	-47.78	5.11	3.00	13.26	-39.63	-13.00	26.63	H
1569.0	-59.31	4.02	3.00	12.21	-51.12	-40.00	11.12	V
2353.5	-54.00	5.11	3.00	13.26	-45.85	-13.00	32.85	V

LTE FDD Band 13_Channel Bandwidth 10MHz_16QAM

Frequency (MHz)	PMea (dBm)	Pcl (dB)	Diatance	Ga Antenna Gain(dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
1564.0	-55.22	4.02	3.00	12.21	-47.03	-40.00	7.03	H
2346.0	-47.48	5.11	3.00	13.26	-39.33	-13.00	26.33	H
1564.0	-57.81	4.02	3.00	12.21	-49.62	-40.00	9.62	V
2346.0	-54.65	5.11	3.00	13.26	-46.50	-13.00	33.50	V

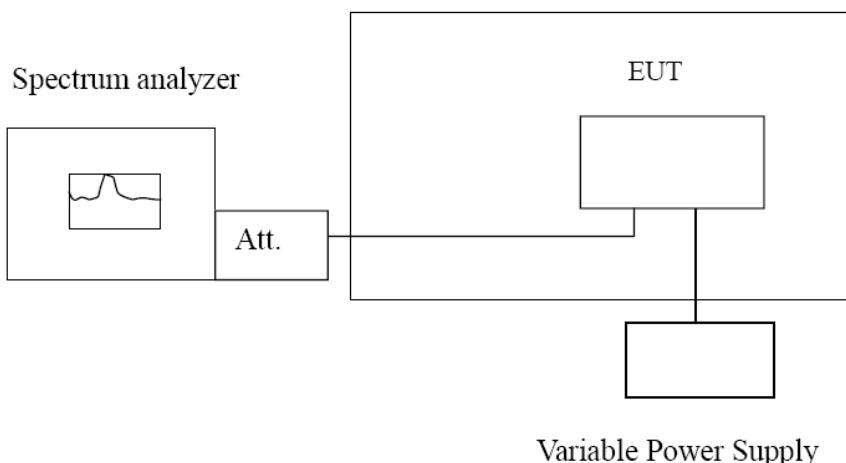
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Temperature Chamber

TEST PROCEDURE

The EUT was setup according to EIA/TIA 603D.

Frequency Stability Under Temperature Variations:

In order to measure the carrier frequency under the condition of AFC lock, it is necessary to make measurements with the EUT in a "call mode". This is accomplished with the use of R&S CMW500 DIGITAL RADIO COMMUNICATION TESTER.

1. Measure the carrier frequency at room temperature.
2. Subject the EUT to overnight soak at -30°C.
3. With the EUT, powered via nominal voltage, connected to the CMW500 and in a simulated call on middle channel for LTE Band 13, measure the carrier frequency. These measurements should be made within 2 minutes of Powering up the EUT, to prevent significant self-warming.
4. Repeat the above measurements at 10°C increments from -30°C to +50°C. Allow at least 1.5 hours at each temperature, unpowered, before making measurements.
5. Re-measure carrier frequency at room temperature with nominal voltage. Vary supply voltage from minimum voltage to maximum voltage, in 0.1 Volt increments re-measuring carrier frequency at each voltage. Pause at nominal voltage for 1.5 hours unpowered, to allow any self-heating to stabilize, before continuing.
6. Subject the EUT to overnight soak at +50°C.
7. With the EUT, powered via nominal voltage, connected to the CMW500 and in a simulated call on the centre channel, measure the carrier frequency. These measurements should be made within 2 minutes of Powering up the EUT, to prevent significant self-warming.
8. Repeat the above measurements at 10 °C increments from +50°C to -30°C. Allow at least 1.5 hours at each temperature, unpowered, before making measurements.
9. At all temperature levels hold the temperature to +/- 0.5°C during the measurement procedure.

Frequency Stability Under Voltage Variations:

Set chamber temperature to 20°C. Use a variable AC power supply / DC power source to power the EUT and set the voltage to rated voltage. Set the spectrum analyzer RBW low enough to obtain the desired frequency resolution and recorded the frequency.

Reduce the input voltage to specify extreme voltage variation ($\pm 15\%$) and endpoint, record the maximum frequency change.

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TEST RESULTS**Remark:**

1. We tested all RB Configuration refer 3GPP TS136 521 for each Channel Bandwidth of LTE Band 13; recorded worst case.

LTE Band 13, 10MHz bandwidth (worst case of all bandwidths)

Frequency Error vs Voltage

Voltage (V)	Frequency error (Hz)		Frequency error (ppm)	
	QPSK	16QAM	QPSK	16QAM
4.25	-1.83	1.99	-0.002340	0.002545
5	-1.95	-3.06	-0.002494	-0.003913
5.75	-2.76	-4.78	-0.003529	-0.006113

Frequency Error vs Temperature

Temperature (°C)	Frequency error (Hz)		Frequency error (ppm)	
	QPSK	16QAM	QPSK	16QAM
-30°	3.63	-2.46	0.004657	-0.003156
-20°	5.26	-3.85	0.006748	-0.004939
-10°	3.28	-1.89	0.004208	-0.002425
0°	2.26	-3.69	0.002899	-0.004734
10°	3.63	-2.30	0.004657	-0.002951
20°	2.52	-2.78	0.003233	-0.003566
30°	3.53	-3.26	0.004529	-0.004182
40°	3.40	-3.15	0.004362	-0.004041
50°	2.32	-1.27	0.002976	-0.001629

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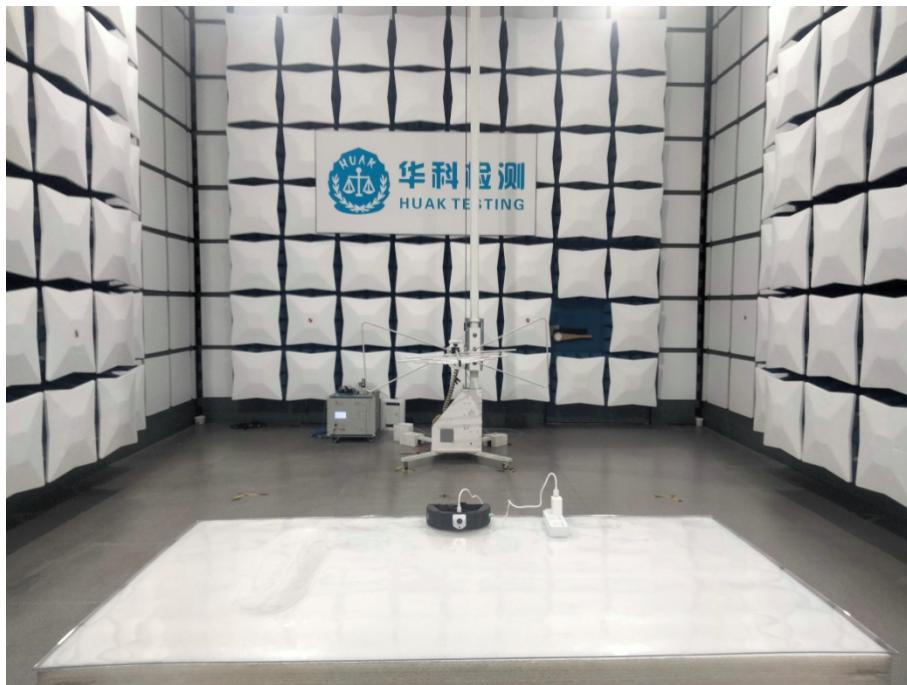
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4 Test Setup Photos of the EUT

Radiated Emission





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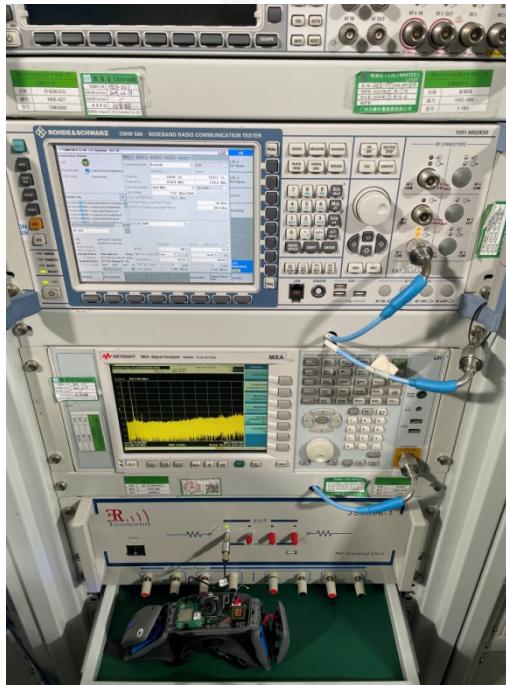


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RF Conducted Emission



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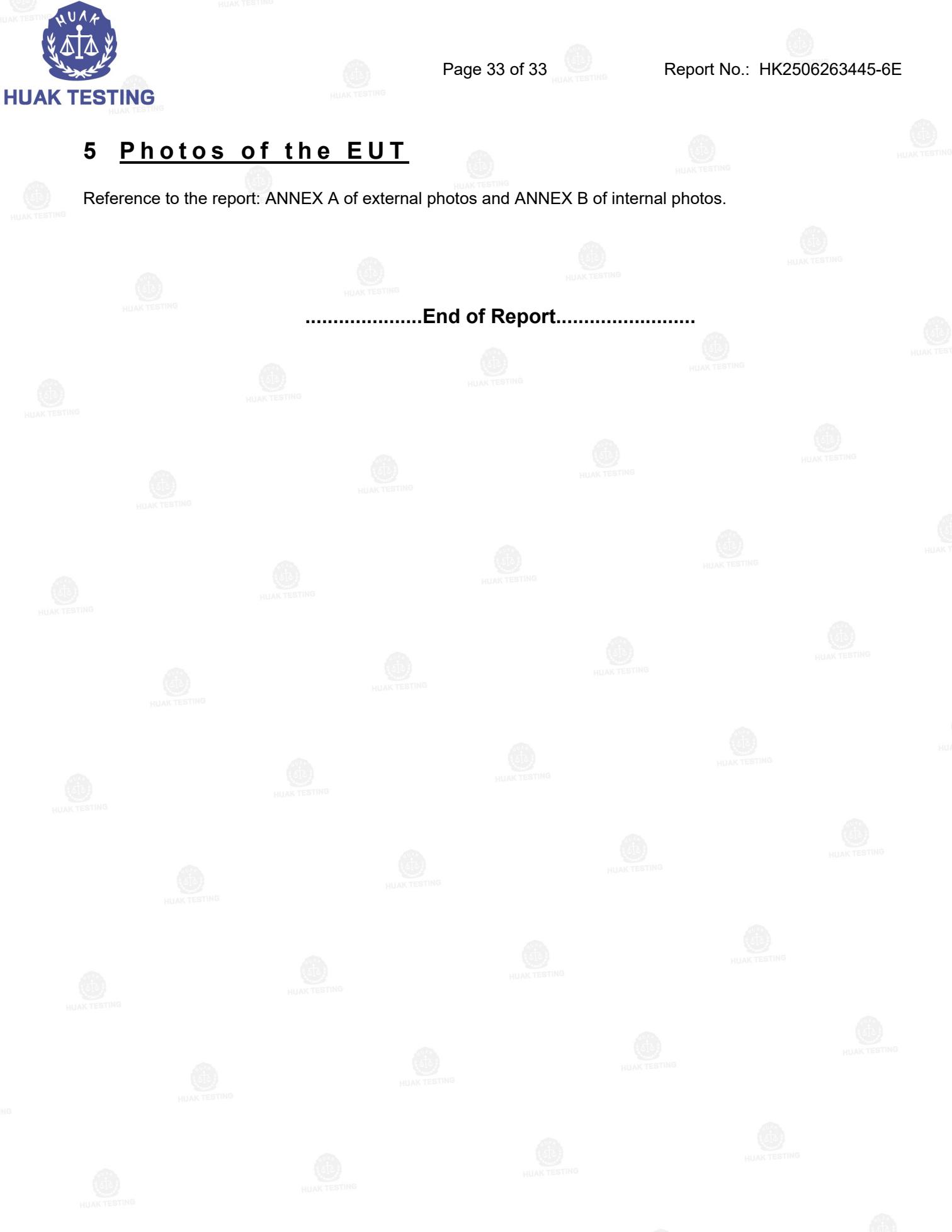
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5 Photos of the EUT

Reference to the report: ANNEX A of external photos and ANNEX B of internal photos.

.....End of Report.....



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